


<b>Search Notes</b> 	<b>Application/Control No.</b> 10811621	<b>Applicant(s)/Patent Under Reexamination</b> SHIH ET AL.
	<b>Examiner</b> EDNA WONG	<b>Art Unit</b> 1795

SEARCHED			
Class	Subclass	Date	Examiner
106	1 26	1/18/06	EW
205	261	1/18/06	EW
205	296	1/18/06	EW
204	194	3/22/09	EW
204	242	3/22/09	EW

SEARCH NOTES		
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Inventor Search	1/18/06	EW
EAST	1/18/06	EW
Search Updated	11/11/06	EW
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Search Updated	7/25/07	EW
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EAST	10/26/07	EW
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Search Updated	9/1/08	EW
Search Updated	11/26/08	EW
Search Updated	3/22/09	EW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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